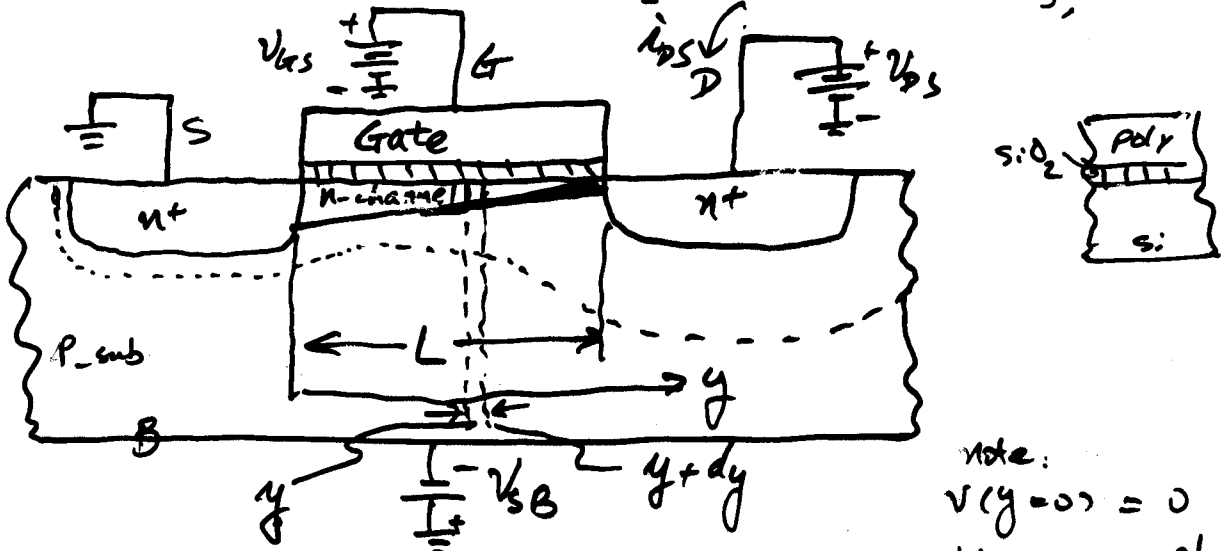


DEVELOPMENT OF LARGE-SIGNAL MODEL FOR
MOSFET FOR SHA ED. AND FOR DSM TECHNOLOGY

SAH MODEL

$$i_D = \frac{k'}{2} \frac{W}{L} (V_{GS} - V_T)^2, \quad V_{DS} \geq V_{GS} - V_T$$

$$i_D = \frac{k'}{2} \frac{W}{L} [2(V_{GS} - V_T)V_{DS} - V_{DS}^2], \quad V_{DS} < V_{GS} - V_T$$



1) charge per unit area at point y in the channel

is $q = CV \rightarrow Q_n(y) = C_{ox} [V_{GS} - V_T - v(y)]$

2) $i_{DS} = Q_n \times v \times W$ where v = carrier velocity

3) Assume $v = \mu E_y = \mu \frac{dv(y)}{dy}$

4) $i_{DS} = i_D = C_{ox} [V_{GS} - v(y) - V_T] \mu E_y W$

$\Rightarrow i_D dy = \frac{\mu C_{ox}}{k} W [V_{GS} - v(y) - V_T] dv(y)$

5) $\int_0^L i_D dy = k' W \int_0^{v_{DS}} [V_{GS} - v(y) - V_T] dv(y)$

$$i_{DL} = k' W [(V_{GS} - V_T) v_{DS} - \frac{v_{DS}^2}{2}]$$

$\Rightarrow i_D = k' \frac{W}{L} [(V_{GS} - V_T) V_{DS} - \frac{V_{DS}^2}{2}], \quad V_{DS} < V_{GS} - V_T$

Linear Region or Triode Region

Saturation Region

No channel length modulation:

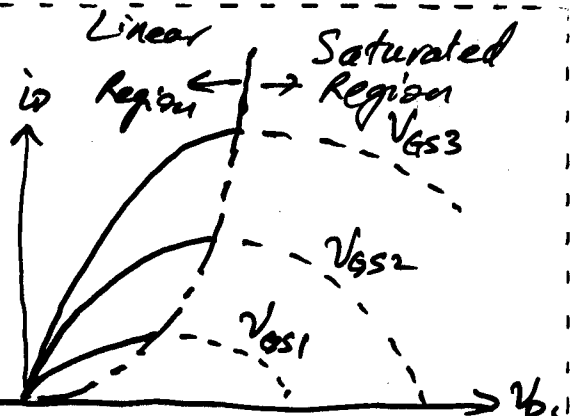
$$i_{DS} = K' \left(\frac{W}{L} \right) \left[(V_{GS} - V_T) V_{DS} - \frac{V_{DS}^2}{2} \right] \rightarrow$$

Peaks occur at $V_{DS} = V_{GS} - V_T$

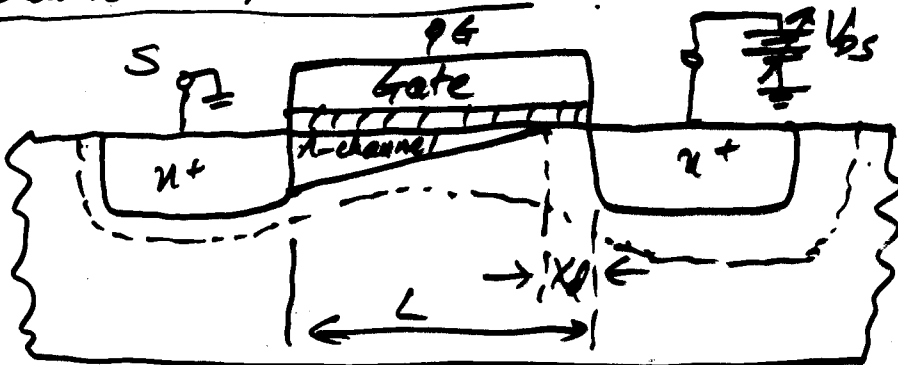
$$V_{DSat} \equiv V_{GS} - V_T$$

When $V_{DS} \geq V_{DSat}$ the drain-source current becomes independent of V_{DS}

$$\therefore i_{DS} = K' \frac{W}{L} \left[(V_{GS} - V_T) V_{DSat} - \frac{1}{2} V_{DSat}^2 \right] = \frac{K'}{2} \left(\frac{W}{L} \right) (V_{GS} - V_T)^2$$



Channel length modulation



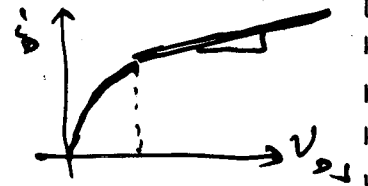
$$L_{eff} = L - x_D$$

$$\therefore i_D = \frac{K'}{2} \left(\frac{W}{L_{eff}} \right) (V_{GS} - V_T)^2 \Rightarrow \frac{di_D}{dV_{DS}} = -\frac{K'}{2} \left(\frac{W}{L_{eff}^2} \right) (V_{GS} - V_T)^2 \frac{dL_{eff}}{dV_{DS}}$$

$$\text{or } \frac{di_D}{dV_{DS}} = -\frac{i_D}{L_{eff}} \frac{dL_{eff}}{dV_{DS}} = \left(\frac{i_D}{L_{eff}} \frac{dx_D}{dV_{DS}} \right) = \lambda i_D$$

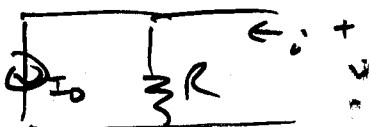
Thus

$$i_D(V_{DS}) = i_D(\lambda=0) + \left(\frac{di_D}{dV_{DS}} \right) V_{DS} \\ = i_D + \lambda i_D = i_D (1 + \lambda V_{DS})$$

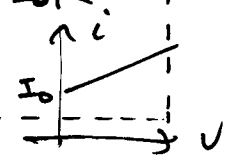


$$\Rightarrow i_D = \frac{K'}{2} \left(\frac{W}{L} \right) (V_{GS} - V_T)^2 (1 + \lambda V_{DS}), \quad V_{DS} \geq V_{GS} - V_T$$

Recall non-ideal current source:



$$i = I_0 + \frac{v}{R} = I_0 + I_0 \frac{v}{I_0 R} \\ = I_0 \left(1 + \frac{1}{R I_0} v \right)$$



DSM? DSM effects:

1) Strong vertical field (tox ↓)

2) Saturation of drift current velocity (L ↓)

$$v = \mu_e E_y / (1 + \frac{E_y}{E_c}) \quad E_y < E_c = \text{critical field}$$

$$v = v_{sat} = \frac{\mu_e E_c}{2} \quad E_y \geq E_c$$

A redevelopment of previous eq. given,

Linear Region: $I_{DS} = \left(\frac{W}{L}\right) \left(\frac{\mu_e}{1 + \frac{v_{DS}}{E_c L}}\right) C_{ox} (V_{GS} - V_T - \frac{v_{DS}}{2}) v_{DS}$ ~~$v_{DS} (1 + \frac{v_{DS}}{E_c L})$~~

Sat. $I_{DS} = W \times C_{ox} \times v_{sat} = W C_{ox} (V_{GS} - V_T - v_{DS}) v_{sat}$
 $= \frac{\mu_e E_c}{2} C_{ox} W (V_{GS} - V_T - v_{DS})$

Equate the above two current to find the intercept point where v_{sat} is defined.

$$\left(\frac{W}{L}\right) \left(\frac{\mu_e C_{ox}}{1 + \frac{v_{DS}}{E_c L}}\right) (V_{GS} - V_T - \frac{v_{DS}}{2}) v_{DS} = \frac{\mu_e E_c}{2} C_{ox} W (V_{GS} - V_T - v_{DS})$$

$$\Rightarrow v_{DS} [L(V_{GS} - V_T) + E_c L] = E_c L (V_{GS} - V_T)$$

$$\Rightarrow v_{DSat} = \frac{(E_c L)(V_{GS} - V_T)}{(V_{GS} - V_T) + (E_c L)} = (E_c L) // (V_{GS} - V_T)$$

If $E_c L \ll V_{GS} - V_T$ short channel $\Rightarrow v_{DSat} \approx E_c L$

$$\Rightarrow I_{DS} = W C_{ox} (V_{GS} - V_T - v_{DSat}) v_{sat}$$

$$= W C_{ox} (V_{GS} - V_T) v_{sat}$$

Linear

If $E_c L \gg V_{GS} - V_T$ long channel $\Rightarrow v_{DSat} = V_{GS} - V_T$

$$\Rightarrow I_{DS} = \frac{\mu_e C_{ox} W}{2} (V_{GS} - V_T)^2 \quad \text{square-law}$$

At sat. $I_{DS} = W v_{sat} C_{ox} \frac{(V_{GS} - V_T)^2}{(V_{GS} - V_T) + E_c L} = \frac{\mu_e C_{ox} W}{2} (V_{GS} - V_T) v_{sat}$